

**Search Notes**

Application/Control No.

10/784,165

Examiner

Ryan D. Walsh

Applicant(s)/Patent under  
Reexamination

KAMEI, CHIKASHI

Art Unit

2852

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
East notes attached: L22		10/31/2005	RDW

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Notes attached text search and 399/ text search	10/31/2005	RDW